

Notice of References Cited	Application/Control No. 10/627,784	Applicant(s)/Patent Under Reexamination OHI ET AL.	
	Examiner Hiep Nguyen	Art Unit 2816	Page 1 of 1

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*	B	US-5,710,508	01-1998	Watanabe, Manabu	323/284
*	C	US-6,057,728	05-2000	Igarashi, Takashi	327/546
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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